


<b>Search Notes</b>  	<b>Application/Control No.</b>  10573350	<b>Applicant(s)/Patent Under Reexamination</b>  BAE ET AL.
	<b>Examiner</b>  Tan Ho	<b>Art Unit</b>  2821

SEARCHED			
Class	Subclass	Date	Examiner
343	700MS, 846	5/22/2009	TH
	Update searched above	12/15/2009	TH

SEARCH NOTES		
Search Notes	Date	Examiner
EAST	5/25/2009	TH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
343	700MS, 846	12/15/2009	TH

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